TEXAS INSTRUMENTS

Data sheet acquired from Harris Semiconductor SCHS103C – Revised July 2003

CMOS Synchronous Programmable 4-Bit Counters

- High-Voltage Types (20-Volt Rating)
- CD40160B Decade with Asynchronous Clear CD40161B – Binary with Asynchronous Clear
- CD40162B Decade with Synchronous Clear CD40163B — Binary with Synchronous
- CD40 103B Binary with Synchronous Clear

■ CD40160B, CD40161B, CD40162B, and CD40163B are 4-bit synchronous programmable counters. The CLEAR function of the CD40162B and CD40163B is synchronous and a low level at the CLEAR input sets all four outputs low on the next positive CLOCK edge. The CLEAR function of the CD40160B and CD40161B is asynchronous and a low level at the CLEAR input sets all four outputs low regardless of the state of the CLOCK, LOAD, or ENABLE inputs. A low level at the LOAD input disables the counter and causes the output to agree with the setup data after the next CLOCK pulse regardless of the conditions of the ENABLE inputs.

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a carry output (C_{OUT}) . Counting is enabled when both PE and TE inputs are high. The TE input is fed forward to enable C_{OUT} . This enabled output produces a positive output pulse with a

Features:

- Internal look-ahead for fast counting
- Carry output for cascading
- Synchronously programmable
- Clear asynchronous input (CD40160B, CD40161B)
- Clear synchronous input (CD40162B, CD40163B)
- Synchronous load control input
- Low-power TTL compatibility
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 µA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package-temperaature range): 1 V at V_{DD} = 5 V
- $2 \text{ V at } \text{V}_{\text{DD}} = 10 \text{ V}$ 2.5 V at $\text{V}_{\text{DD}} = 15 \text{ V}$
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

duration approximately equal to the positive portion of the Q1 output. This positive overflow carry pulse can be used to enable successive cascaded stages. Logic transitions at the PE or TE inputs may occur when the clock is either high or low.

The CD40160B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix). The CD40161B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

The CD40160B through CD40163B types are functionally equivalent to and pin-compatible with the TTL counter series 74LS160 through 74LS163 respectively.

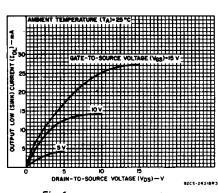
14____01 PE IC TE 13 92 CLEAR LOAD 12 03 CLOCK PI 1 04 P2 P3 15 CARRY VDD - 16 V_{SS} • 8 92CS - 28628RI Functional Diagram

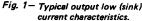
CD40160B, CD40161B.

CD40162B, CD40163B Types

Applications:

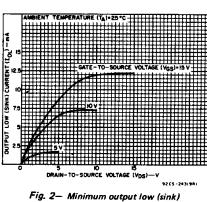
- Programmable binary and decade counting
- Counter control/timers
- Frequency dividing





MAXIMUM RATINGS, Absolute-Maximum Values:

| DC SUPPLY-VOLTAGE RANGE, (V _{DD}) | |
|--|---------------------|
| Voltages referenced to VSS Terminal) | 0.5V to +20V |
| INPUT VOLTAGE RANGE, ALL INPUTS | 0.5V to Vnn +0.5V |
| DC INPUT CURRENT, ANY ONE INPUT | ±10mA |
| POWER DISSIPATION PER PACKAGE (PD): | |
| For $T_A = -55^{\circ}C$ to $+100^{\circ}C$ | |
| For $T_A = +100^{\circ}C$ to $+125^{\circ}C$ Derate Linearity a | t 12mW/ºC to 200mW |
| DEVICE DISSIPATION PER OUTPUT TRANSISTOR | |
| FOR T _A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) | |
| OPERATING-TEMPERATURE RANGE (TA) | 55°C to +125°C |
| STORAGE TEMPERATURE RANGE (Tstg) | 65°C to +150°C |
| LEAD TEMPERATURE (DURING SOLDERING): | |
| At distance 1/16 \pm 1/32 inch (1.59 \pm 0.79mm) from case for 10s max | +265 ⁰ C |



current characteristics.

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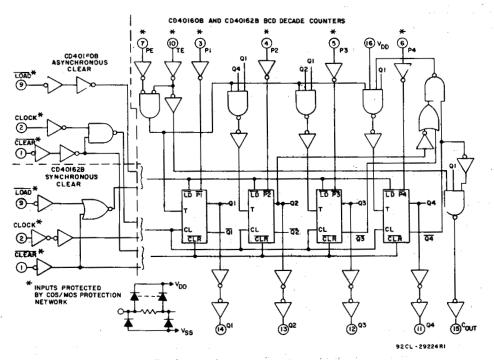


Fig. 3- Logic diagrams for CD40160B and CD40162B BCD decade counters.

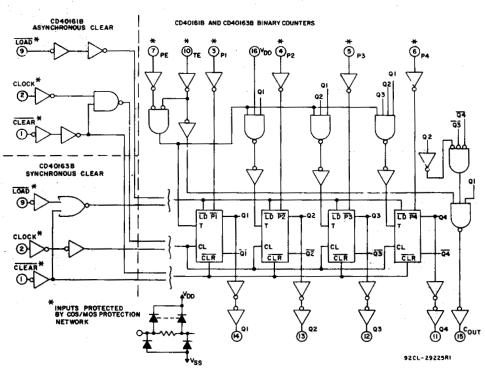
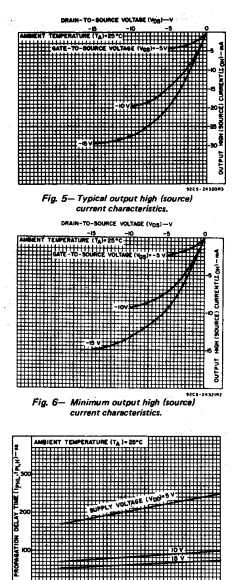


Fig. 4- Logic diagrams for CD40161B and CD40163B binary counters.

| CHARACTERISTIC | v _{DD} | LIM | UNITS | |
|--|-----------------|-------------------|-----------------|-----|
| | (V) | MIN. | MAX. | |
| Supply Voltage Range (Full T _A = Full Package - Temperature Range) | _ | 3 | 18 | v |
| Setup Time: t _{SU} Data to Clock | 5 10 15 | 240 90 60 | ····· | ns |
| Load to Clock | 5 10 15 | 240 90 60 | ÷ - * | ns |
| PE or TE to Clock | 5 10 15 | 340 140 100 | - | П\$ |
| Clear to Clock (CD40162B, CD40163B) | 5 10 15 | 340 140 100 | · _ , | ns |
| All Hold Times, t _H | 5 10 15 | 0 0 0 | - · | ns |
| Clear Removal Time, t _{rem} (CD40160B, CD40161B) | 5 10 15 | 200 100 70 | | ns |
| Clear Pulse Width, t _{WL} (CD40160B, CD40161B) | 5 10 15 | 170 70 50 | · _ | ns |
| Clock Input Frequency, f _{CL} | 5 10 15 | - | 2 5.5 8 | MHz |
| Clock Pulse Width, t _W | 5 10 15 | 170 70 50 | - | ns |
| Clock Rise or Fall Time, t _r CL or t _f CL | 5 10 15 | - | 200 70 15 | μs |

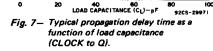
RECOMMENDED OPERATING CONDITIONS at $T_A = 25^{\circ}C$, Except as Noted For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

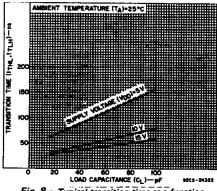


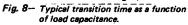
3

COMMERCIAL CMOS

HIGH VOLTAGE ICs







TRUTH TABLE

| CLOCK | CLR | LOAD | PE | TE | OPERATION |
|----------|-----|------------|----|----|----------------------------|
| 5 | 1 | 0 | × | x | PRESET |
| 5 | 1 | 1 | 0 | x | NC |
| 5 | 1 | 1. | × | 0 | NC |
| 7 | 1 | 1 | 1 | 1 | COUNT |
| x | 0 | • x | x | x | RESET (CD40160B, CD40161B) |
| <u> </u> | .0 | x | x | х | RESET (CD40162B, CD40163B) |
| | 1 | x | x | x | NC (CD40162B, CD40163B) |

1 = HIGH LEVEL

0 = LOW LEVEL X = DON'T CARE

NC = NO CHANGE

STATIC ELECTRICAL CHARACTERISTICS

| CHARAC- TERISTIC | CON | DITIO | NS | | | .IMITS TEMPE | | | | | U N I T |
|---|----------|-------|-----|----------|-------|-----------------|-------|-------|-------------------|------------------|------------------|
| | Vo | VIN | VDD | | | | | | +25 | | s |
| | (Ň) | (Ÿ) | (v) | 55 | -40 | +85 | +125 | Min. | Тур. | Max. | |
| Quiescent | - | 0,5 | 5 | 5 | 5 | 150 | 150 | - | 0.04 | 5 | |
| Device | | 0,10 | 10 | 10 | 10 | 300 | 300 | + | 0.04 | 10 | μA |
| Current, IDD Max. | | 0,15 | 15 | 20 | 20 | 600 | 600 | | 0.04 | 20 | Ϊ. |
| .00.000 | | 0,20 | 20 | 100 | 100 | 3000 | 3000 | - | 0.08 | 100 | Ι. |
| Output Low (Sink)Current I _{OL} Min. | 0.4 | 0,5 | 5 | 0.64 | 0.61 | 0.42 | 0.36 | 0.51 | . 1 | - | |
| | 0.5 | 0,10 | 10 | 1.6 | 1.5 | 1.1 | 0.9 | 1.3 | 2.6 | _ | 1 |
| | 1.5 | 0,15 | 15 | 4.2 | 4 | 2.8 | 2.4 | 3.4 | 6.8 | - | |
| Output High (Source) Current, IOH Min. | 4.6 | 0,5 | 5 | -0.64 | -0.61 | -0.42 | -0.36 | -0.51 | 1 | _ | m/ |
| | 2.5 | 0,5 | 5 | 2 | -1.8 | -1.3 | -1.15 | -1.6 | -3.2 | · _ | 1 |
| | 9.5 | 0,10 | 10 | 1.6 | -1.5 | -1.1 | -0.9 | -1.3 | -2.6 | - | |
| | 13.5 | 0,15 | 15 | 4.2 | -4 | -2.8 | -2.4 | -3.4 | -6.8 | | 1 |
| Output Voltage: | - | 0,5 | 5 | • | 0. | .05 | - | 0 | 0.05 | | |
| Low-Level, | - | 0,10 | 10 | | 0 | .05 | | - | . 0 | 0.05 | 1. |
| VOL Max. | - | 0,15 | 15 | | 0. | .05 | | - | 0 | 0.05 | ا ر |
| Output | - | 0,5 | 5 | 1998 | 4. | .95 | | 4.95 | 5 | - | |
| Voltage: High-Level, | _ | 0,10 | 10 | | 9. | .95 | | 9.95 | 10 | - | 1 |
| VOH Min. | _ | 0,15 | 15 | in ' | , 14, | .95 , | | 14.95 | 15 | | |
| Input Low | 0.5,4.5 | - | 5 | | | 1.5 | | - | · · | 1.5 | |
| Voltage | 1,9 | _ | 10 | 4 | | 3 | | | | 3 | 1 |
| V _{IL} Max. | 1.5,13.5 | 1 | 15 | | | 4 | | - | — . | 4 | . v |
| Input High | 0.5,4.5 | - | 5 | · · · | | 3.5 | | 3.5 | · _] | | |
| Voltage, | 1,9 | | 10 | đ | - | 7 | | 7 | - . | . . . | |
| V _{IH} Min. | 1.5,13.5 | - | 15 | | | 11 | | 11 | | - | |
| Input Current I _{IN} Max. | 1 | 0,18 | 18 | ±0.1 | ±0.1 | ±1 | ±1 | - | ±10 ⁻⁵ | ±0.1 | μ٨ |

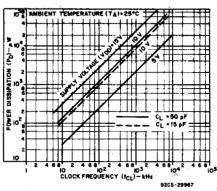


Fig. 9— Typical power dissipation as a function of CLOCK frequency.

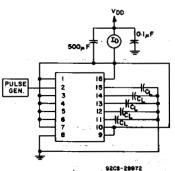


Fig. 10- Dynamic power dissipation test circuit.

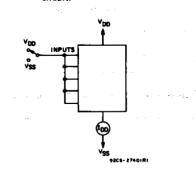
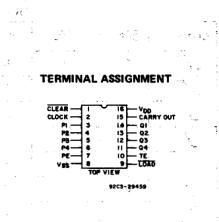
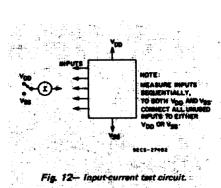
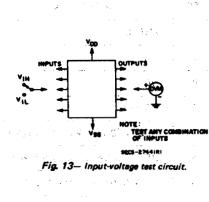


Fig. 11- Quiescent-device-current test circuit.



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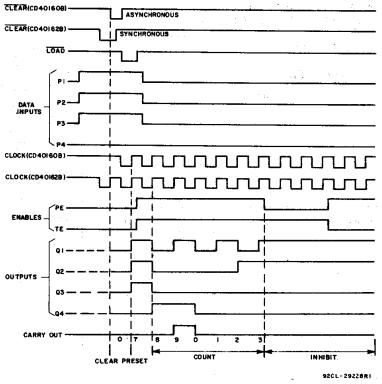
15.1

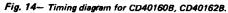
| CHARACTERISTIC | TEST CONDITIONS | | | UNITS | | |
|--|---------------------|--|----------------|-----------|----------|--|
| | V _{DD} (V) | Min. | Typ. | Max. | 1 | |
| CLOCK OPERATION | | | · · · · | | 4 | |
| Propagation Delay Time, tpHL,tpLH | 5 | - | 200 | 400 | T | |
| Clock to Q | | - | 80 | 160 | ns | |
| | 15 | L - | 60 | 120 | | |
| · · · · · · · · · | 5 | | 225 | 450 | | |
| Clock to COUT | -10 | 1 <u>-</u> | 95 | 190 | ns | |
| | 15 | · _ | 70 | 140 | | |
| | 5 | <u> </u> | ł | | | |
| TE to COUT | 10 | · - | 125 | 250 | | |
| | 15 | - | 55 40 | 110 | ns | |
| · · · · · · · · · · · · · · · · · · · | | <u>+ </u> | | 80 | | |
| Minimum Setup Time, tSU | 5, . | - | 120 | 240 | ſ | |
| Data to Clock | 10 👌 | 1 · - | 45 | 90 | ns | |
| · · · · · · · · · · · · · · · · · · · | 15 | | 30 | 60 | | |
| | 5 | _ | 120 | 240 | | |
| Load to Clock | 10 | | 45 | 90 | ns | |
| | 15 | _ | 30 | 60 | 113 | |
| and the second sec | 5 | <u></u> | | | | |
| PE to TE to Clock | | - 1 | 170 | 340 | | |
| FE TO FE TO CHOCK | 10 | [— | 70 | 140 | ns | |
| | 15 | | 50 | 100 | | |
| | 5 | · — | - | 0 | | |
| Minimum Hold Time, t _H | 10 | | - 1 | o | ns | |
| | 15 | _ | - 1 | Ō | | |
| to the total data we are | Carries 5 Charles | . <u> </u> | 100 | 200 | | |
| Transition Time, t _{THL} ,t _{TLH} | 10 | | 50 | | | |
| | 15 | - | 40 | 100 | ns | |
| | | | | 80 | L | |
| | 5 | - | 85 | 170 | ŀ | |
| Minimum Clock Pulse Width, t _W | 10 | - | 35 | 70 | ns | |
| | 15 | | 25 | 50 | | |
| | 5 | 2 | 3 | _ | | |
| Maximum Clock Frequency, f _{CL} | 10 | 5.5 | 8.5 | <u> </u> | MHz | |
| 02 | 15 | 8 | 12 | - | | |
| | 5 | 200 | | | <u> </u> | |
| Maximum Clock Rise or Fall Time, [†] | 10 | 70 | - | - | | |
| t _r CL, t _{fCL} | 15 | 15 | • • - • | - | μs | |
| | 13 | 15 | <u> </u> | | | |
| | | | 050 | | | |
| Propagation Delay Time, tpHL | 5 | | 250 | 500 | | |
| (CD40160B, CD40161B) | 10 | | 110 | 220 | ns | |
| Clear to Q | | - ` | ··· 80 | 160 | | |
| winning on setup time, t <u>st</u> | 5 | - | 170 | 340 | | |
| (CD40162B, CD40163B) | .10 | . . | 70 | 140 | ns | |
| Clear to Clock | 15 | | 50 | 100 | | |
| Minimum Hold Time, t _H | 5 | _ | | 0 | 1 | |
| (CD40162B, CD40163B) | 10 | _ | | . 0 | | |
| Clear to Clock | 15 | | | 0 | ns | |
| | | | | | ļ | |
| Minimum Clear Removal Time, t _{rem} | 5 | | 100 | 200 | | |
| (CD40160B, CD40161B) | 10 | · — | 50 | 100 | ns | |
| | 15 | · + | 35 | 70 | | |
| | | | | | | |
| | 5 | | 85 | 170 | | |
| Minimum Clear Pulse Width, tWL (CD40160B, CD40161B) | 5 10 | I. | 85 35 | 170 70 | ns | |

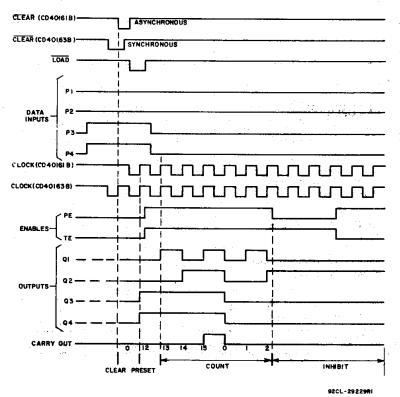
DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25° C; Input t_r, t_f = 20 ns, C_L = 50 pF, R_L = 200 k Ω

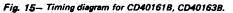
* Except as noted.
* Except as noted.
* If more than one unit is cascaded in the parallel clocked application, trCL should be made less than or equal to the sum of the fixed propagation delay at 50 pF and the transition time of the carry output driving stage for the estimated capacitive food.

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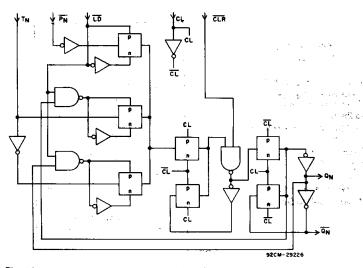
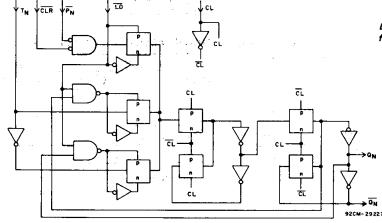


Fig. 16- Detail of flip-flops of CD40160B and CD40161B (asynchronous clear).



80 80-88 4-10 ____ 106 - 114 ____ (2.693 - 2.895) 92CM-29968

Dimensions and pad layout for CD40160BH. Dimensions and pad layout for CD40161BH, CD40162BH, and CD40163BH are identical.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch).

92CM- 29970

COMMERCIAL CMOS HIGH VOLTAGE ICS

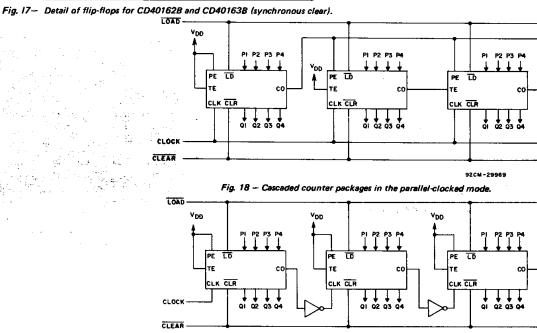


Fig. 19 - Cascaded counter packages in the ripple-clocked mode.



PACKAGING INFORMATION

| Orderable Device | Status | Package Type | • | Pins | • | Eco Plan | Lead finish/ | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|---------|------|------|---------------------|----------------------|--------------------|--------------|----------------|---------|
| | (1) | | Drawing | | Qty | (2) | Ball material (6) | (3) | | (4/5) | |
| CD40160BF3A | ACTIVE | CDIP | J | 16 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | CD40160BF3A | Samples |
| CD40161BE | ACTIVE | PDIP | Ν | 16 | 25 | RoHS & Green | NIPDAU | N / A for Pkg Type | -55 to 125 | CD40161BE | Samples |
| CD40161BF3A | ACTIVE | CDIP | J | 16 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | CD40161BF3A | Samples |
| CD40161BNSR | ACTIVE | SOP | NS | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD40161B | Samples |
| CD40161BPWR | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CM0161B | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD40161B, CD40161B-MIL :

- Catalog : CD40161B
- Military : CD40161B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

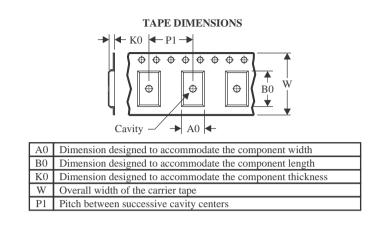
www.ti.com

Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | | | | | | | | |
|-----------------------------|-------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | • | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| CD40161BNSR | SOP | NS | 16 | 2000 | 330.0 | 16.4 | 8.2 | 10.5 | 2.5 | 12.0 | 16.0 | Q1 |
| CD40161BPWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |



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PACKAGE MATERIALS INFORMATION

7-Dec-2024



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CD40161BNSR | SOP | NS | 16 | 2000 | 356.0 | 356.0 | 35.0 |
| CD40161BPWR | TSSOP | PW | 16 | 2000 | 356.0 | 356.0 | 35.0 |

TEXAS INSTRUMENTS

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TUBE



- B - Alignment groove width

*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | Τ (μm) | B (mm) |
|-----------|--------------|--------------|------|-----|--------|--------|--------|--------|
| CD40161BE | N | PDIP | 16 | 25 | 506 | 13.97 | 11230 | 4.32 |
| CD40161BE | N | PDIP | 16 | 25 | 506 | 13.97 | 11230 | 4.32 |

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

NS0016A



PACKAGE OUTLINE

SOP - 2.00 mm max height

SOP



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- Per ASME Y14.5M.
 This drawing is subject to change without notice.
 This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



NS0016A

EXAMPLE BOARD LAYOUT

SOP - 2.00 mm max height

SOP



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



NS0016A

EXAMPLE STENCIL DESIGN

SOP - 2.00 mm max height

SOP



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

8. Board assembly site may have different recommendations for stencil design.



PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



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